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Can we reach fast growth methods for Coated Conductors at competitive costs ?

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T. Puig- EUCAS 2019



Acknowledgements

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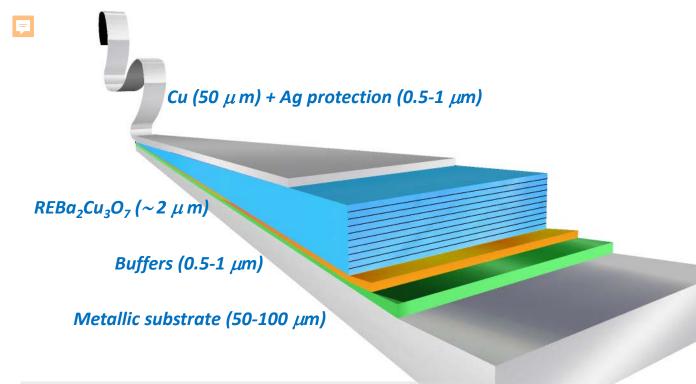
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H. Lee, M. Moon, *SuNAM Co, Gyeonggi-do, Korea* A. Usoskin, U. Betz, *Bruker HTS BmbH, Alzenau, Germany* Y. Yamada, *Shangai Superconductor Technology Co, Pudong Shanghai, P.R. China*





REBCO is the opportunity and the challenge at high magnetic fields



 I_c (77K, sf) ~ 500 A/cm-w (for 500 m -1 km piece length) I_c (4.2 K, 20 T) ~ 1000 A/cm-w (with nanocomposites)

25-yr of Coated Conductor technology development



Pros:

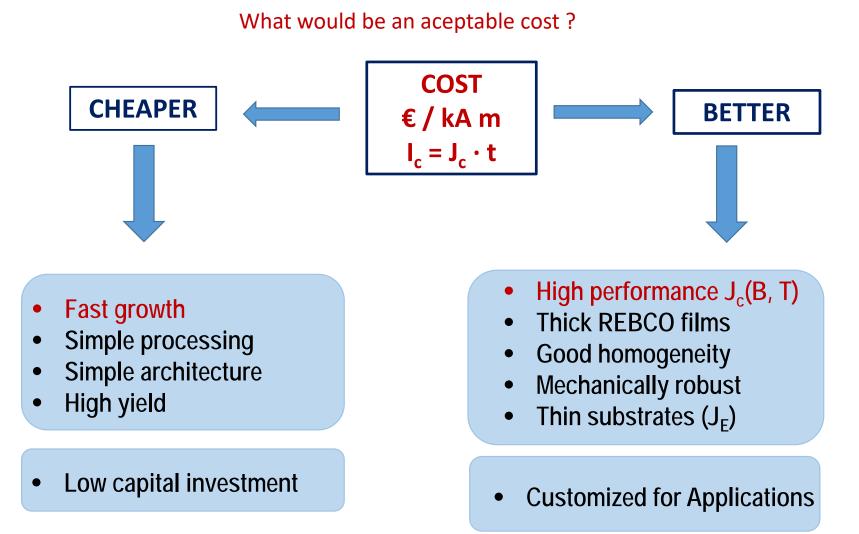
- High T_c
- High H_{c2}
- High J_c
- High IL

Cons:

- Grain boundaries
- Anisotropy
- Small coherence length (nanometric pinning centres)
- High thermal excitations
- Robustness
- Biaxial texture ⇒ high cost
 Cost= €/ kA-m

How to decrease cost of Coated Conductors

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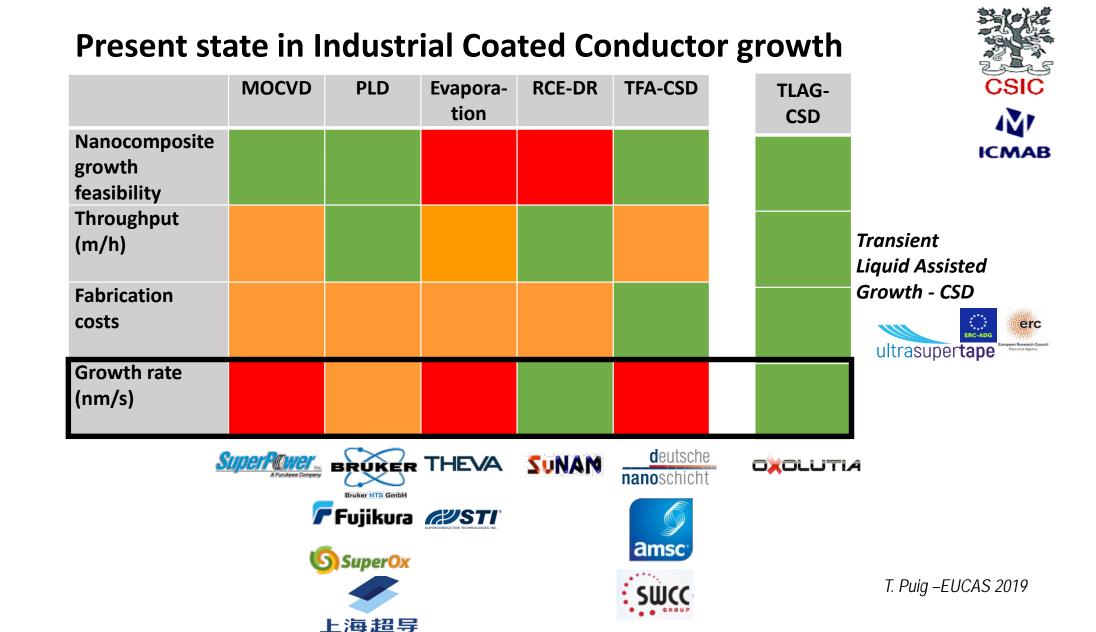


EXCELENCIA SEVERO OCHOA **NANOCOMPOSITES** PLD (also for MOCVD) 20nm CSD

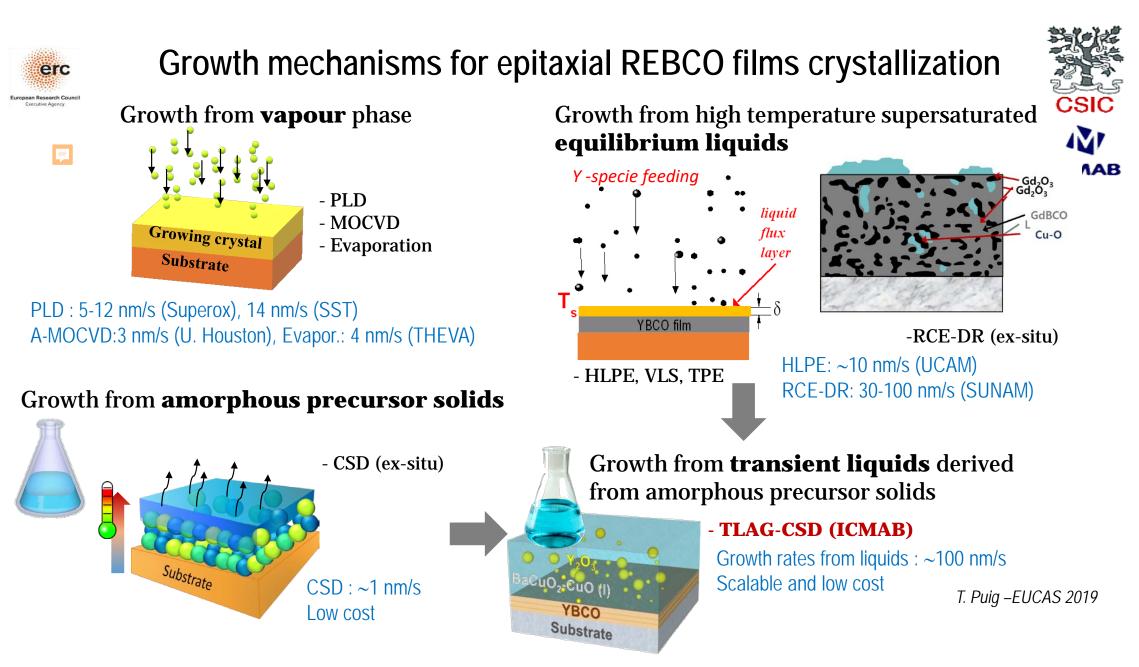
S. Kang, Science 311 (2006), J. Guiterrez, Nat Mat 11 (2007)

200 nm





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Fast growth processing of CC and its compatibility with high currents

- Instrinsic factors:
- High growth rates
- Growth mechanisms
- Materials growth rate (YBCO, GdBCO,..)



High manufacturing rates

for in-situ growth methods (PLD, MOCVD, evaporation)

- High deposition velocity
- High deposition area
- Multi-plume
- Multi-lane
- PLD high power and frequency laser,...
- Nanocomposites might be compromised

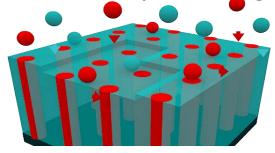
for ex-situ growth methods (RCE-DR, CSD, TLAG-CSD)

- Independent deposition and growth processes
- Multi-turn deposition
- Furnaces dimensions
- High deposition area
- Nanoparticles may not be compromised
- Some high growth rate processes are being used





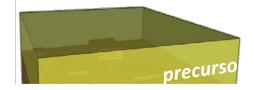
In-situ growth methods Simultaneous deposition and growth



PLD@Bruker and PLD@SST

Ex-situ growth methods

Sequential deposition and growth



RCE-DR@SuNAM and TLAG@ICMAB





BRUKER HTS GmbH



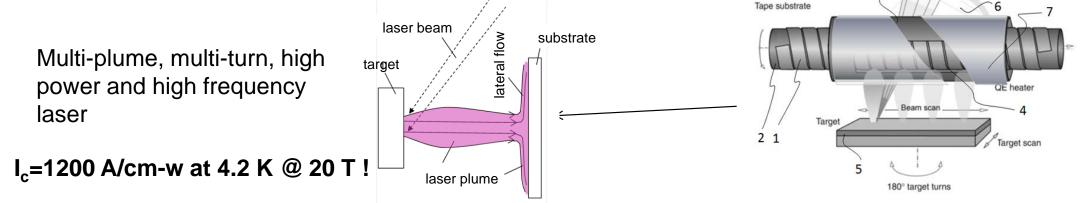
Scanning mirror

Quartz window

in vacuum chambe

- The processing speed of long length DD YBCO films by Pulsed Laser Deposition is performed in a dynamic mode. Main impact factors on the processing speed are:
 - Target properties
 - Beam scan parameters
 - Substrate rotation and movement
 - Process environment (T, p)
- The deposition rate in the static mode exceeds

150 nm/s at the maximum of the local film thickness distribution





Imaging lens

Strategy for "fast growth" in PLD at SST



Multi-plume- Multi-lane PLD: typical growth rate in a mass-production is Average rate= **20nm/sec** between 10-50nm/sec (**tape speed 120m/hr**)

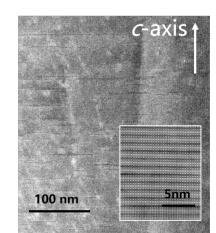
Need to balance between I_c and production speed

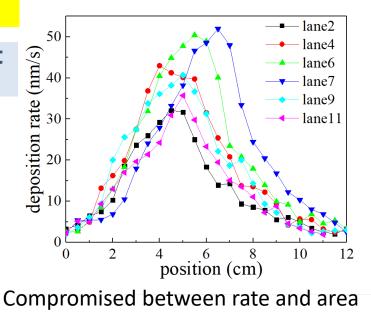
High deposition rate makes more stacking faults and high /_c at low temperatures. \rightarrow favorable for realistic industry operation

High /_c with SF without columnar structutre

 I_c =1200 A/cm-w at 4.2 K @ 17 T !

Material: $Y \rightarrow Gd$ (production speed was doubled.)





Next strategy:

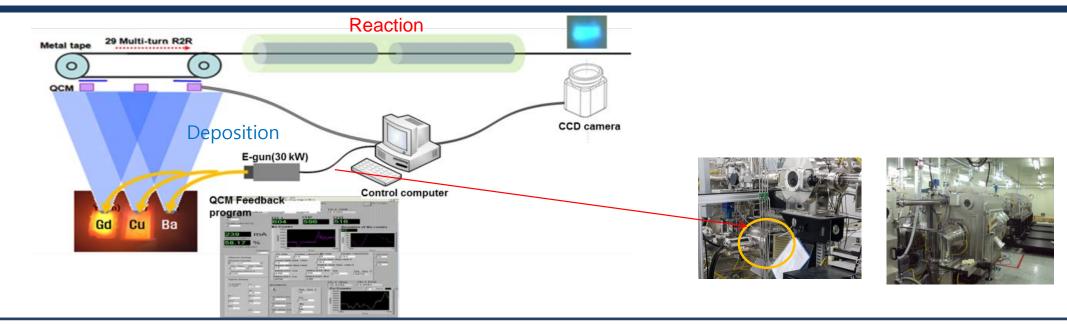
Material: $Y \rightarrow Gd$, APC



Re-survey for high rate, wide temp. range, PO2 (stability in production)



Introduction of RCE-DR process & system



- RCE-DR : Reactive Co-Evaporation by Deposition & Reaction (SuNAM, R2R)
- High rate co-evaporation at low temperature & pressure to the target thickness(> 1 μm) at once in deposition zone (6 ~ 10nm/s) 120 m/h tape speed
- Fast conversion(up to 100 nm/sec) from amorphous glassy phase to superconducting phase at high temperature and oxygen pressure in reaction zone
- Simple, high deposition rate & area, low system cost
- Easy to scale up :single path
- Verified for Gd, Y, Sm,



I_c=750 A/cm-w at 77 K,sf !

PLD RCE-DR TLAG-CSD Growth rate (nm/s)5-10 ~100 100 (16 for LA-PLD*) **Deposition velocity** High power laser 6-10 nm/s **Multi-lane pyrolysis Multi Plum** multiturn 8 furnace length **Multi-lane** evaporation Drum **Deposition area** High High High **Reel-to-reel adaptation** Achieved Achieved Easy 120 m/h 60 m/h (pyrolysis) Tape speed 120 m/h (SST) Limited by 700 m/h (growth) deposition speed 150 nm/s (BRUKER) 100 nm/s Average 20 nm/s (SST) manufacturing rate X number of parallel tapes

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* Cambridge Liquid-assisted PLD variant

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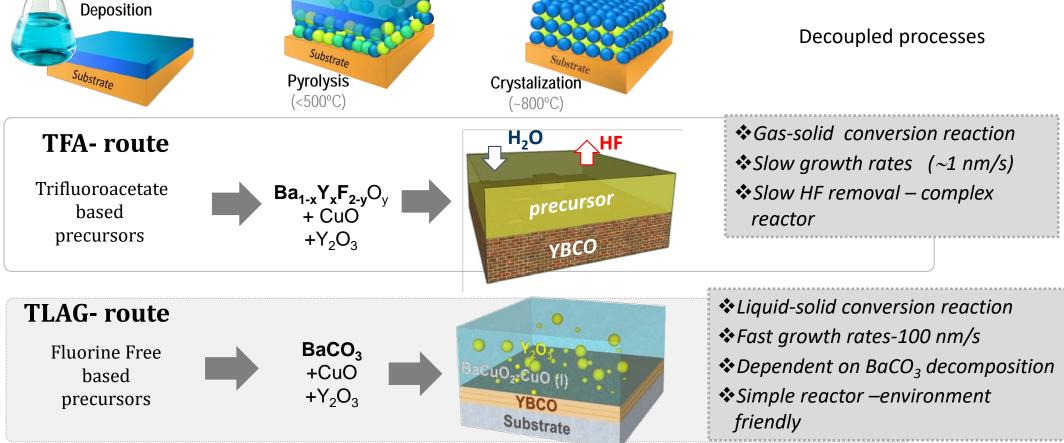


CSIC

ICMAB

YBCO-CSD Growth methods

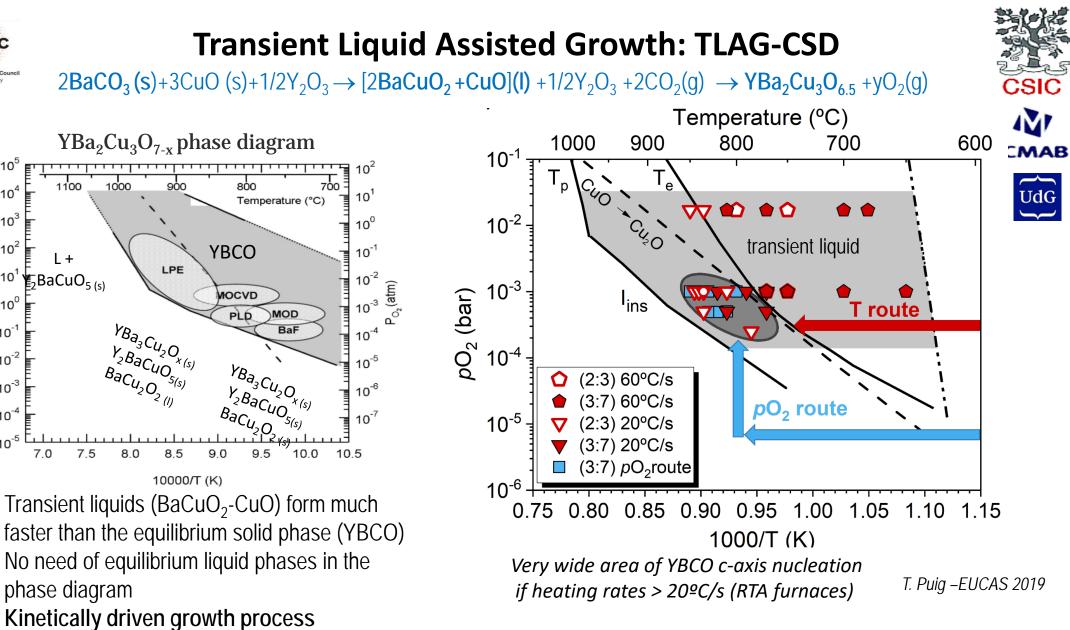




TLAG = Transient Liquid Assisted Growth

Solution +

BaCO₃ decomposition is not an issue SEVERO OCHOA After pyrolysis After growth (T, P_{02} , P_{total} , heating ramp, composition...) **ÝBCO** In-situ XRD at Soleil sync. ACO THE (003)/(100)/(010) Y_2O_3 Temperature / °C Ba₂Cu₃O₆ 600 650 700 750 800 850 ntensity / a.u. a.u 98868600868686 -00000000 Intensity YBCO BaCO $1 \,\mu m$ thick BaCO₂ orth. epitaxial layers 25 30 20 20 25 30 2θ/⁰ 2θ/⁰ BaCO 600 650 700 750 800 850 Temperature / °C **YBCO** Decomposition in seconds at high heating rates CuO BaCO, c-YBCO 10-30 nm See 3-MO-CU-02S (J. Bancheswki), 3-MO-CU-04S (S. Rasi) 20 nm 200 nm 20 nm





10⁵

10⁴

 10^{3}

10²

10

10⁰

10

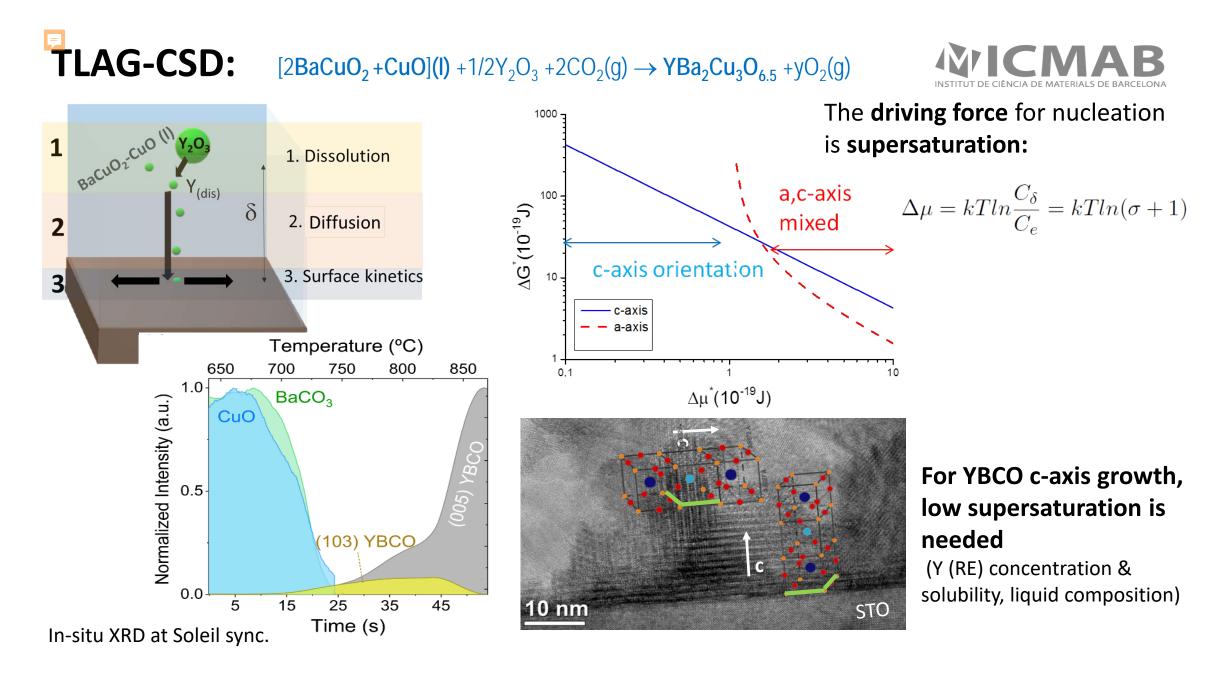
10-2

10⁻³

10-4

 10^{-5}

P_{O2}(Torr)

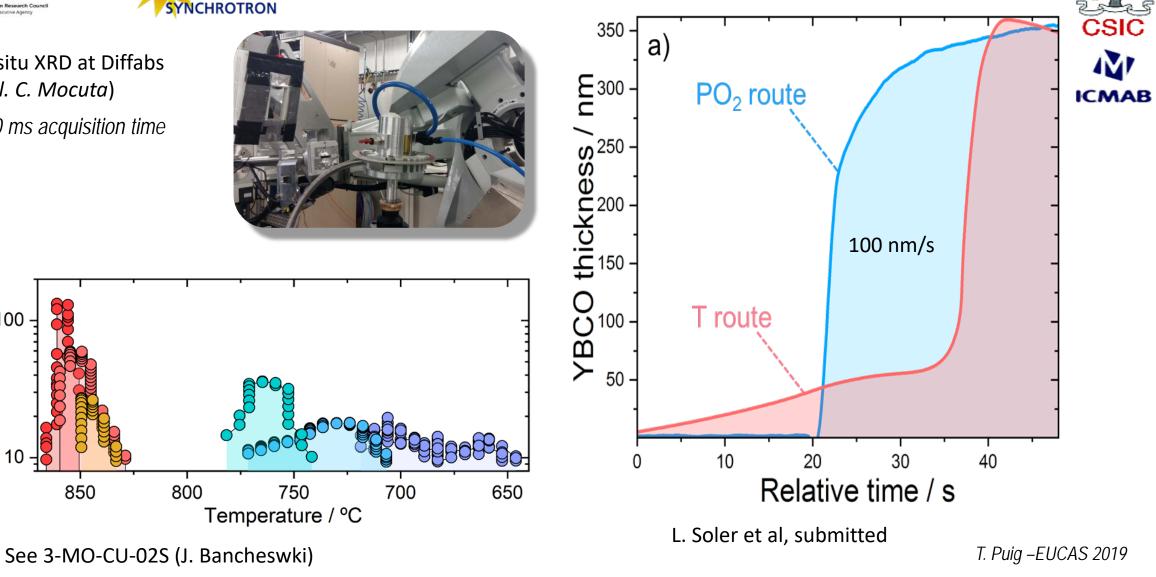




Ultrafast growth by TLAG-CSD

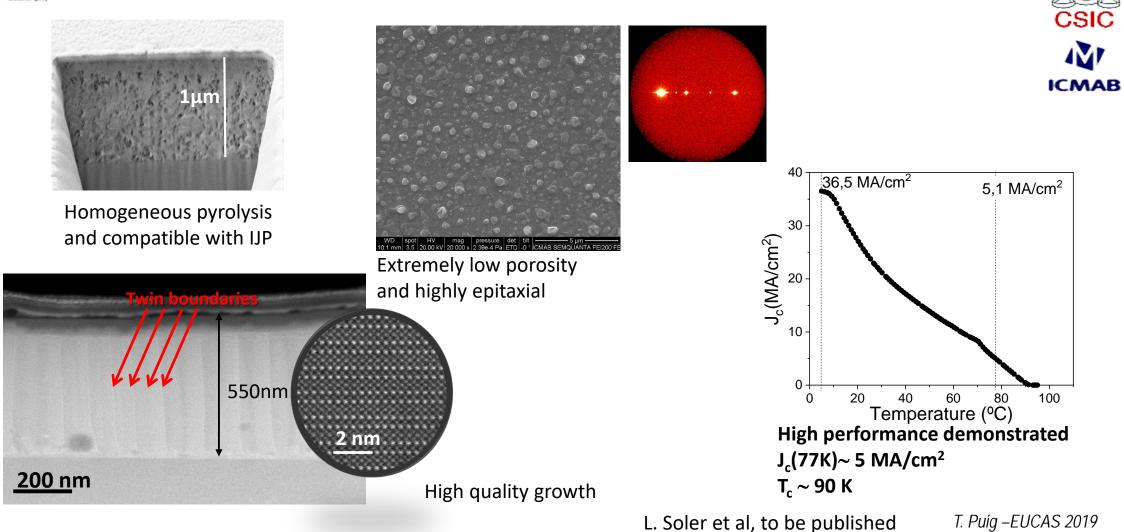
In-situ XRD at Diffabs (col. C. Mocuta) 100 ms acquisition time

Growth rate / nm·s⁻¹

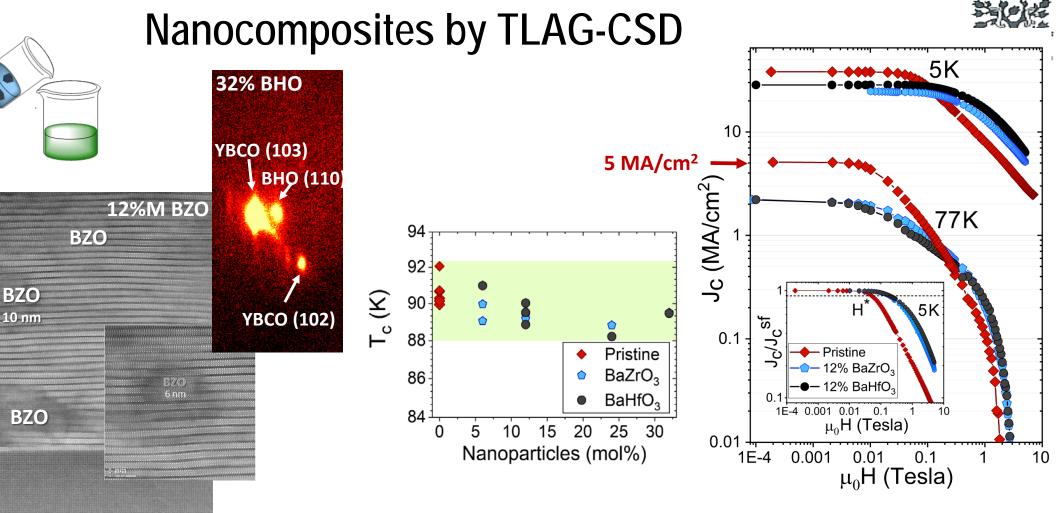


European Research Council

Transient Liquid Assisted Growth (TLAG-CSD) films



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In-field performances of TLAG nanocomposite outperform pristine films

L. Soler et al, submitted

Very high density of defects and small epitaxial nanoparticles in nanocoposites

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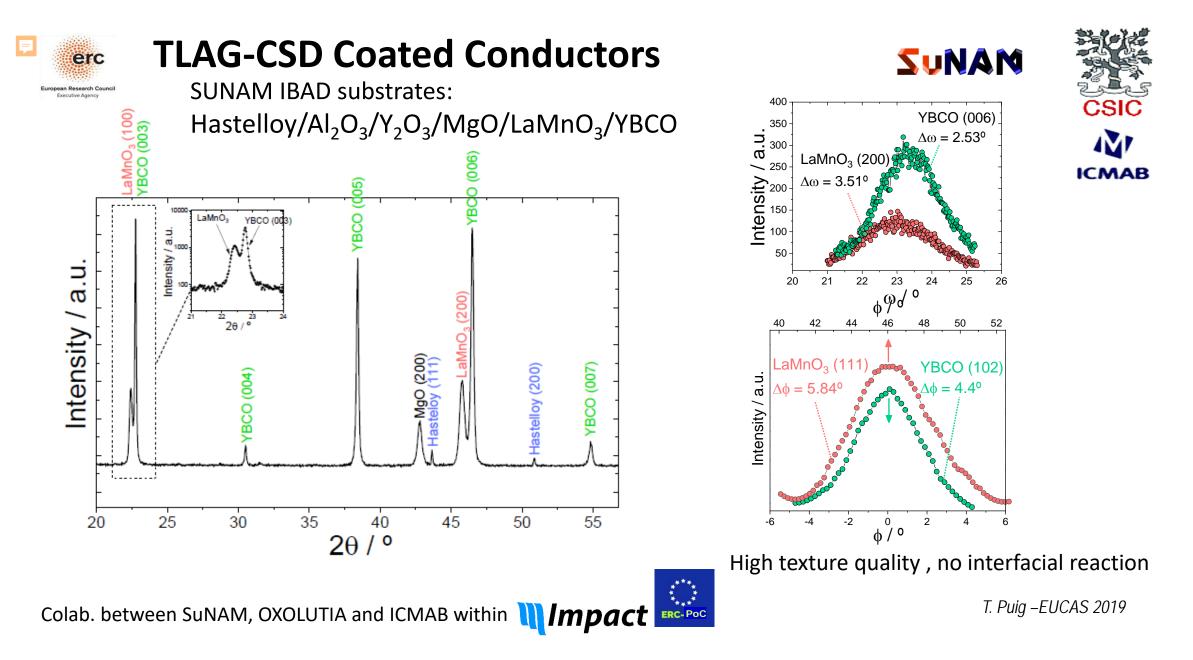
Research Counci

STO

20 nm

Executive Agen

See 2-MO-FP1-05S (X. Obradors) and 1-MPCC1-102 (A. Queralto) for opportunities with Ink Jet Printing T. Puig – EUCAS 2019

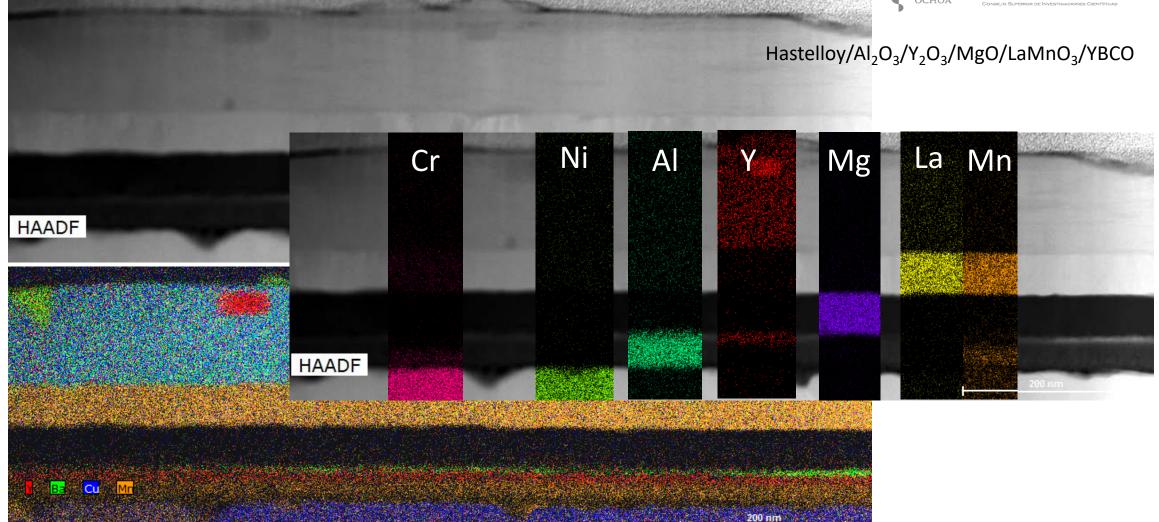




TLAG YBCO coated conductor

TEM-EDX analysis: Homogeneous layers and clean interfaces without reactivity





Conclusions and prospectives



- HTS coated conductors have reached impressive performances also at high magnetic fields
- Strategies are being followed to decrease cost/performance ratio. In particular by:
 - 1. Increasing manufacturing rates
 - 2. Using high growth rate processes like those assisted by liquids
- Very good prospectives are envisaged for PLD, RCE-DR and TLAG-CSD concerning fast fabrication rates
- TLAG-CSD is a new opportunity combining very high growth rates of 100 nm/s with CSD methods and nanocomposites growth